4 JUL 96 Rev. A

EUROCARD CONNECTORS TYPES B, C, C-SWITCH, M, R, D, F AND G.

1. SCOPE.

1.1. Content.

This specification covers the performance, test and quality requirements for the AMP* EUROCARD connectors.

They are receptacle and pin 2-piece connectors, which provide a connection method on 2,54 mm centerline (type B, C, C-Switch, M and R) and 5,08 mm centerline (type D, F and G). Connectors are available in 2 row and 3 row fully loaded or selective loaded configurations. Switching positions type C-Switch connector are according VME bus J1/P1 connector pin assignments. Switching positions row a21-22, row b 4-5, 6-7, 8-9 and 10-11.

1.2. Qualification.

If tests are performed on the product line, the procedures specified in IEC publication 512 shall be used unless otherwise specified. All inspections shall be performed using the applicable inspection plan and product drawing.

2. APPLICABLE DOCUMENTS.

This product specification is based upon DIN 41612 part 5 dated 1987 / IEC 603-2 dated 1995. The following documents form a part of this specification to the extent specified herein. In the event of conflict between the requirements of this specification and the product drawing, the product drawing shall take precedence. In the event of conflict between the requirements of this specification and the referenced documents, this specification shall take precedence.

IEC Publication 603-2	Connectors for frequencies below 3 MHz
IEC Publication 512	Test Specification
DIN 41612 part 1/IEC 603-2	Common mounting features, survey of types.
DIN 41612 part 2/IEC 603-2	Dimensions of type B, C, M and D.
DIN 41612 part 3/IEC 603-2	Dimensions of type F and G.
DIN 41612 part 5/IEC 603-2	Rating, requirements and tests.
DIN 41612 part 6/IEC 603-2	Dimensions of type R.

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DATE 5-7-96

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3.0 REQUIREMENTS.

3.1. Design and Constructions.

Connectors shall be of the design, construction and physical dimensions specified on the applicable product drawing and DIN 41612 part 2/IEC 603-2 (for type B, C and D) part 3 (for type F and G) part 6 (for type R) and part 8 (for type M).

3.2. Materials.

a. Terminals:

Receptacle

: Phosphor Bronze

Pin

: Brass of Phosphor Bronze

Clip for C-Switch

: Brass

b. Housing

: Thermoplastic, glassfilled, UL94V0/UL94V1.

3.3. Ratings.

a1. Type B, C, C-Switch, M and R. Current 1,5 A max. per contact at 20° and 1,0 A max. per contact at 75°.

a1. Type D, F and G. Current 5,5 A max. per contact at 20° and 4,0 A max. per contact at 75°.

b1. Operating temperature : -55°C to 125°C.

3.4. Ratings addendum for C-Switch.

- a1. Switching under power 5 V 100 mA min. 500 switching cycles.
- b1. Capacity switching contacts ≤ 10 pF.
- Normal force switch contact ≥ 0,1 N.
- d1. Retention force for displacement of jumper clip $\geq 4 \text{ N}$.

NOTE:

The continuous current rating for the individual contacts cannot be applied directly to the number of contacts as they depend on the thermal and physical properties of the materials. System design shall assure that continuous current rating does not create internal hot spots that exceed the temperature designated by the connector specifications, during steady-state or transient conditions.

3.4. Performance and Test Description.

Connectors shall be designed to meet the electrical, mechanical and environmental performance requirements specified in group A till group E.



4.0 QUALITY ASSURANCE PROVISIONS.

4.1. Qualification Testing.

A. Sample Selection

Connector housing and contacts shall be selected at random from current production.

B. Test Sequence

Qualification inspection shall be verified by testing samples specified in group A till E.

C. Acceptance.

- a. All samples tested in accordance with this specification shall meet the stated tolerance limit.
- b. Failures attributed to equipment, test set-up, or operator deficiencies shall not disqualify the product. When product failure occurs, corrective action shall be taken and sample resubmitted for qualification.

4.2. Quality Conformance Inspection.

The applicable AMP* inspection plan will specify the sampling acceptable quality level to be used. Dimensional and functional requirements shall be in accordance with the applicable product drawing and this specification.

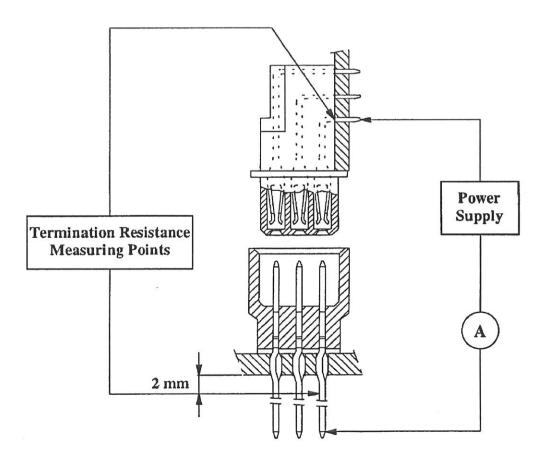
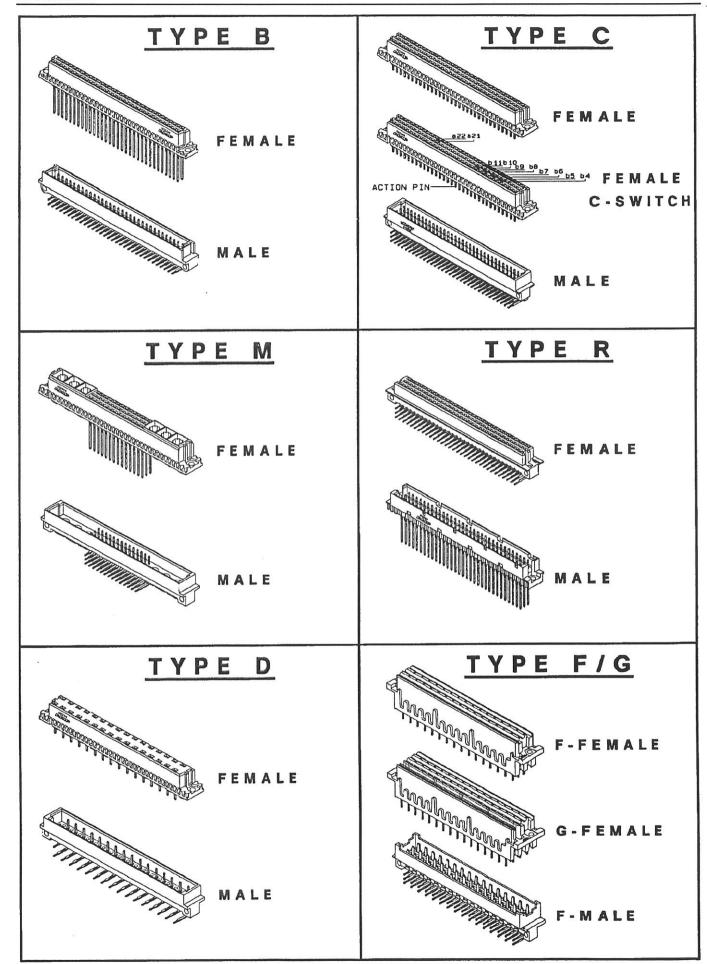


Figure 1







All specimen shall be subjected to the following tests:

26 samples of Class I connectors 20 samples of Class II connectors 8 samples of Class III connectors

The specimens shall be divided into five groups. All connectors in each group shall undergo the tests specified for the relevant group.

phase		IEC	Test	Measureme to be perfor				F	Require	ement	s		
Test ph	Title	Publ. 512 part	Severity or condition of test	Title	Publ. 512 part	B64	C96 R96 M42 M60 M78	C64 R64	C32 R32	D32	F48	F32	G64
P1	General examination		Unmated connectors	Visual examination Dimensional examination	-2 Test 1a Test 1b	the test land clearance shall comply with those spaces of the field in Sub-clause 4.2 to 4.4 and 6.2.1. Test IEC 603-2.					ose sp .2.1.	eci- of	
P2	Polarization method	-7 Test 13e				It sha the a It sha		ossibl iate m oe pos	nating sible t	conne o mate	ctors.	onnec	
Р3			Connection points as in Figure 1 6 contacts/specimen	Contact resistance	-2 Test 2a		20 m [©]	Ω max			15 mΩ	2 max	•
P4	For Class I and II		Test voltage 100 ±15 V	Insulation resistance	-2 Test				10 ⁶ N	lΩ mir	1		
	For Class III		Method A 3 contacts		3a				10 ⁵ M	Ω min			
P5			Contact/contact	Voltage proof	-2 Test	1 00	0 V (r.	m.s.)		1 550) V (r.	m.s.)	
			Contact/test panel	ρισσι	4a		1 550) V (r.	.m.s.)		2 500) V (r.	m.s.)



Group A

6 samples of Class I connectors 4 samples of Class II connectors 4 samples of Class III connectors

ase		IEC	Test	Measurem to be perfo				F	Requir	ement	s		
Test phase	Title	Publ. 512 part	Severity or condition of test	Title	Publ. 512 part	B64	C96 R96 M42 M60 M78	C64 R64	C32 R32	D32	F48	F32	G64
AP1	Gauge retention force for Class I and II	-8 Test 16e	Female contacts only 5 contacts/ specimen Sizing tool P11 Gauge P12 per IEC 603 par 5.1 Sizing tool P21 Gauge P22 per IEC 603-2 par. 5.1.			X	0,15	X N min	. X	X 0,15N min.			
			Sizing tool P31 Gauge P33 per IEC 603-2 par 5.1	,							X 0.	X 2 N m	X
AP2	Insertion and withdrawal force	-7 Test 13b				60N max.	90N max.	60N max.	30N max	30N max.	75N	50N max.	100N
AP3	Soldering	-6 Test 12a	(under consideration)			Х	Х	Х	Х	х	Х	Х	Х
AP4			Contact/contact	Voltage	-2	1 00	0 V (r.	m.s.)		1 55	0 V (r	.m.s.)	
			Contact/ test panel	proof	Test 4a		1 55	0 V (r	.m.s.)		2 50	0 V (r	.m.s.)
AP5								N	lot ap	plicab	le		
AP6	Vibration Class I Vibration	-4 Test 6d	10Hz-2000Hz 1,5 mm or 20g Duration: 6 h 10Hz-500 Hz	Variation of contact resistance: connection points as in	-2 Test 2c		40 mº	2 max		33	30 m	Ω max	
	Class II	Ju	0,35 mm or 5 g Duration: 6 h	Subclause 7.1							2	Anna and the same	



ise		IEC '	IEC Test Measurement to be performed Requirements										
Test phase	Title	Publ. 512 part	Severity or condition of test	Title	Publ. 512 part	2 B64 M42 B64 B35 D32 F48 F32							G64
AP7	Shock for Class I	-4 Test 6c	50g (490 m/s²) half sine shape 11 millisecond, 3 shocks in each direction, applied along 3 mutually perpendicular planes	Variation of contact resistance. Same connection points as in P3.	-2 Test 2c	t ≤ 40 mΩ ≤ 30 mΩ							
AP8								n	ot app	olicabl	е		
AP9	Rapid change of temperature for Class I and II	-6 Test 11d	-55°C + 125°C 0,5 hr each temp. 5 cycles			x x x x x x x							х
AP 10	For Class I and II		100 ± 15V Method A 3 contacts	Insulation resistance	-2 Test 3a	st $\geq 10^{\circ} M\Omega$ min.							
AP	For Class		contact/contact	Voltage	2	1 000	0 V (r.	m.s.)		1 550) V (r.	m.s.)	
11	I and II		contact/test panel	proof	Test 1a		1 550) V (r.	m.s.)		2 500) V (r.	m.s.)
AP 12	For Class I and II		Unmated	Visual examination	-2 Test 1a		No	damag	je due	to co	nditio	ning	
AP 13	Climatic sequence		+ 125°C. unloaded	Insulation resistance	-2								
AP 13.1	Dry heat Class I and II		duration 16 hrs Recovery time:	at high temperature	Test 3a				≥ 10 [!]	⁵ ΜΩ			
	Class III		2 hrs						≥ 10 [°]	4 M Ω			
AP 13.2	Damp heat, accel. First cycle Class I and II	-6 Test 11a	Upper temp.: Recovery time: 2 hrs	Class I + 55°C. Class II + 40°C		X X X X X X X X X X							х
AP 13.3	Cold		-55°C Recovery time: 2 hrs			x x x x x x x							х
AP 13.4	Low air pressure Class I and II		300 mbar + 15°C to 35°C	Voltage proof Contact/ contact	-2 Test 4a	t 300 V (r.m.s.) 500 V (r.m.s.)							



				T		Т							
phase		IEC	Test	Measureme to be perfor				F	Require	ement	s		
Test pha	Title	Publ. 512 part	Severity or condition of test	Title	Publ. 512 part	B64	B64 R96 C6 M42 C6 M60 M78		C32 R32	D32	F48	F32	G64
AP 13.5	Damp heat accel. Remaining cycles Class I and II		upper temp. Recovery time 2 hrs	Class I +55°C. Class II +40°C		x x x x				х	X	x	х
AP	Class I and II		100 ±15 V	Insulation	2			≥	10 ⁴ N	4 M Ω min			
14	Class III		Method A 3 contacts	resistance	Test 2a			≥	10 ³ N	/lΩ mi	in.		
AP 15			Connection points as in P3 6 contacts/ specimen	Contact resistance	-2 Test 2a		≤ 20	mΩ			≤ 15	mΩ	
AP	Class		Contact/contact	Voltage	2	1 000	0 V (r.	m.s.)		1 550) V (r.	m.s.)	
16	I and II		Contact/test panel	proof	Test 4a		1 550) V (r.	m.s.)		2 500	0 V (r	.m.s.)
AP 17				Insertion and withdrawal force	-7 Test 13b	60N max	90N max	60N max	30N max	30N max	75N max	50N max	100N max
AP 18			Unmated	Visual examination	-2 Test 1a		No d	amag	e due	to co	onditio	oning	



Group B

8 samples of Class I connectors 4 samples of Class II connectors 4 samples of Class III connectors

ase		IEC	Test	Measurem to be perfor				F	Require	ement	nts			
Test phase	Title	Publ. 512 part	Severity or condition of test	Title	Publ. 512 part	B64	C96 R96 M42 M60 M78	C64 R64	C32 R32	D32	F48	F32	G64	
BP1	Insertion and withdrawal force	-7 Test 13b				60N max	90N max	60N max	30N max	30N max	75N max	50N max	100N max	
	Gauge retention force	-8 Test 16e					≥ 0,	15N			≥0,	20N		
BP2	Mechanical endurance	-5 Test 9a	250 operations for Class I 200 operations for Class II 25 operations for Class III Speed 10 mm/s (0.4 in/s) Rest 30 s (when unmated)			×	×	x	×	x	×	x	x	
BP3	Industrial atmosphere (other half of group): half mated: half unmated for Class I and II	-6 Test 11g	IEC 68-2-42 except 10 ppm SO ₂			Cla	ass I 2	21 da	ys	C	lass I	I 4 da	ays	
BP4			Connection points as in P3 6 contacts/ specimen	Contact resistance	-2 Test 2a	2	20 m2	2 max	۲.	1	∫5 mΩ	2 max	۲.	
BP5	Mechanical endurance	-5 Test 9a	250 operations for Class I 200 operations for Class II 25 operations for Class III Speed 10 mm/s (0.4 in/s) Rest 30 s (when unmated)			x	x	Х	х	x	x	Х	х	



phase		IEC	Test	Measureme to be perfor											
Test ph	Title	Publ. 512 part	Severity or condition of test	Title	Publ. 512 part	I. B64 R96 R96 R64 R32 D32 F48 R64 R32						F32	G64		
BP6	For Class I and II		100 ±15 V Method A 3 contacts	Insulation resistance	-2 Test 3a	est 10° M Ω min.									
BP7	For Class		Contact/contact	Voltage	2										
	I and II		Contact/test panel	proof	Test 4a		1 550) V (r.	m.s.)		2 500) V (r.	m.s.)		
BP8								Ν	ot ap	plicab	le				
BP9			Gauge P12	Gauge	0		0.15	N min							
			Gauge P22	retention force	-8 Test 16e					0.15N min.					
			Gauge P32								0.:	2 N m	in.		
BP 10			Unmated	Visual examination	-2 Test 1a	t No damage due to conditioning									
BP 11	Static load axial	-5 Test 8b	Force increase 10N/sec max.									100N			



Group C

4 samples of Class I connectors 4 samples of Class II connectors

phase		IEC :	Test	Measurem to be perfor				F	Require	rements					
Test ph	Title	Publ. 512 part	Severity or condition of test	Title	Publ. 512 part	2 B64 M42 B64 B35 D32 F48					F32	G64			
CP1	Damp heat steady state	-6 Test 11c	56 days		x x x x x x						Х	Х			
CP2			100 ±15V Method A 3 contacts	Insulation resistance	-2 Test 3a			1	0 ⁴ M	Ω mir	١.				
CP3			Connection points as in P3 6 contacts/ specimen	Contact resistance	-2 Test 2a	2	20 mΩ	2 max	ζ.	1	5 mΩ	2 max	(.		
CP4			Contact/contact	Voltage	2	1 000	0 V (r.	m.s.)		1 550) V (r.	m.s.)			
			Contact/test panel	proof	Test 4a	t I						.m.s.)			
CP5				Visual examination	-2 Test 1a	No damage due to conditioning									

Group D

- 4 samples of Class I connectors 4 samples of Class II connectors

phase		IEC	Test	Measureme to be perfor		Requirements							
Test ph	Title	Publ. 512 part	Severity or condition of test	Title	Publ. 512 part	B64	C96 R96 M42 M60 M78	C64 R64	C32 R32	D32	G64		
DP1	Mechanical endurance		as in P3 250 operations for Class I 200 operations for Class II							4 A			
DP2	Electrical endurance	-5 Test 9b	1000 h +70°C				1	Α					
DP3			Connection points as in P3 6 contacts/ specimen	Contact resistance	-2 Test 2a		20 m <u></u>	Ω max	K	1	5 mΩ	2 max	ζ.
DP4			Contact/contact	Voltage	2	1 00	0 V (r.	.m.s.)		1 550) V (r.	.m.s.)	
			Contact/test panel	proof	Test 4a		1 550	0 V (r.	.m.s.)		2 50	0 V (r	.m.s.)
DP5			Contact/contact Contact/test panel	Partial discharge	-2 Test 4b			1	000	V mir	٦.		
DP7				Visual examination	-2 Test 1a	No damage due to conditioning							



Group E

4 samples of Class I connectors 4 samples of Class II connectors

phase		IEC	Test	Measurem to be perfor				F	Require	ement	s			
Test ph	Title	Publ. 512 part	Severity or condition of test	Title	Publ. 512 part	2 B64 M42 B6차 B35 D32 F48 F32 여							G64	
EP1	Robustness of terminations	-8 Test 16f	Test Ua			20N min.								
EP2	Contact retention	-8 Test 15a					10	N		5N		10N		
EP3	Mold growth	-6 Test 11e	28 days			Cer	tificat	ion b	y plas	tic m	ateria	l sup	plier	
EP 3.1				Visual examination	-2 Test 1a	t No damage due to conditioning								